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Application Number	10/725,890
Filing Date	DECEMBER 2, 2003
First Named Inventor	STEVEN E. WALAK
Art Unit	3739
Examiner Name	N/A
Attorney Docket Number	1001.1632101

[illegible]

FOREIGN PATENT DOCUMENTS						
Examiner Initials*	Cite No.	Foreign Patent Document	Publication Date	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages Or Relevant Figures Appear	T
		Country Code ¹ Number ² Kind Code ³ (if known)	MM-DD-YYYY			
/B.O./		WO 2003/041783	05/22/2003	SciMed Life Systems...		
/B.O./		JP 2000254235 - Abstract	09/19/2000	TERUMO CORP		

/Bradley Osinski/


09/17/2007

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FORM PTO-1449* INFORMATION DISCLOSURE STATEMENT 	Atty. Docket No.: 1001.1632101	Serial No.: 10/725,890
	Applicant: STEVEN E. WALAK	
	Confirmation No.: 3380	
	Filing Date: DECEMBER 02, 2002	Group Art: 3739

IN AN APPLICATION
(Use several sheets if necessary)

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	DOCUMENT NO.	DATE	COUNTRY	CLASS	TRANSLATION	
					YES	NO

OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.)

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